Se	arch	No	tes

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Application/Control No.	Applicant(s)/Patent under Reexamination
09/276,233	SHAMOON ET AL.
Examiner	Art Unit
Patrick J. Santos	2161

	SEAR	CHED	, <u>-</u>
Class	Subclass	Date	Examiner
709	231	2/4/2005	PJS
713	171	2/4/2005	PJS
719	315	2/4/2005	PJS

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	1		

SEARCH I (INCLUDING SEAR	NOTES CH STRATEG	Y)
	DATE	EXMR
EAST	2/4/2005	PJS
IEEE INSPEC/Google	2/4/2005	PJS
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